

AOK40B120P1

1200V, 40A Alpha IGBT™

With Soft and Fast Recovery Anti-Parallel Diode

General Description

- 1200V latest Alpha IGBT (αIGBT) technology
- Very low $V_{\text{CE(sat)}}$
- · High short-circuit ruggedness
- Very low turn-on EMI
- · Easy paralleling capability
- Low gate charge Q_g
- · High efficiency and ruggedness in hard switching converters
- Maximum junction temperature 175°C
- · Very soft and fast recovery anti-parallel diode

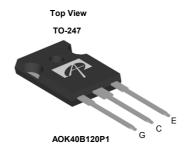
Applications

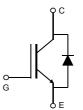
- Industrial UPS
- · Motor drives
- Solar Inverters
- Welding converters

Product Summary

 $\begin{array}{ll} V_{CE} & 1200V \\ I_{C} \; (T_{C} \! = \! 100^{\circ} \! C) & 40A \\ V_{CE(sat)} \; (T_{J} \! = \! 25^{\circ} \! C) & 1.83V \end{array}$







Orderable Part Number		Packa	age Type	Form	Minimum Order Quantity		
AOK40B120P1			O247	Tube	2	240	
Absolute Maximum I	Ratings T _A =2	5°C unless of	therwise noted	•	•		
Parameter			Symbol	AOK40B120P1		Units	
Collector-Emitter Voltage			V _{CE}	1200		V	
Gate-Emitter Voltage			V_{GE}		±30		
Continuous Collector Current	T _C =25°C T _C =100°C		-I _C		80		
					40	— A	
Pulsed Collector Current, Limited by T _{Jmax}			I _{CM}		160	A	
Turn-Off SOA, V _{CE} ≤ 1200V, Limited by T _{Jmax}		by T _{Jmax}	I _{LM}		160	А	
Continuous Diode Forward Current	T _C =25°C				80		
	T _C =100°C	I _F			40	— A	
Diode Pulsed Current, Limited by T _{Jmax}		max	I _{FM}		160	A	
Short Circuit Withstanding Time (1)			t _{sc}	10			
V _{GE} =15V, V _{CC} ≪600V, T _J ≪175°C					10	μs	
Power Dissipation	T _C =25°C		D		600	w	
	T _C =100°C		$-P_D$		300	vv	
Junction and Storage Temperature Range		Range	T _J , T _{STG}	-58	5 to 175	°C	
Maximum Lead Temperature for Soldering Purpose, 1/8" from case for 5 seconds			T _L	300		°C	
Thermal Characteris	tics			•		•	
Parameter			Symbol	AOK	40B120P1	Units	
Maximum Junction-to-Ambient			$R_{\theta JA}$	40		°C/W	
Maximum IGBT Junction-to-Case			$R_{\theta JC}$		0.25	°C/W	
Maximum Diode Junction-to-Case			$R_{\theta JC}$		0.4	°C/W	

⁽¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.

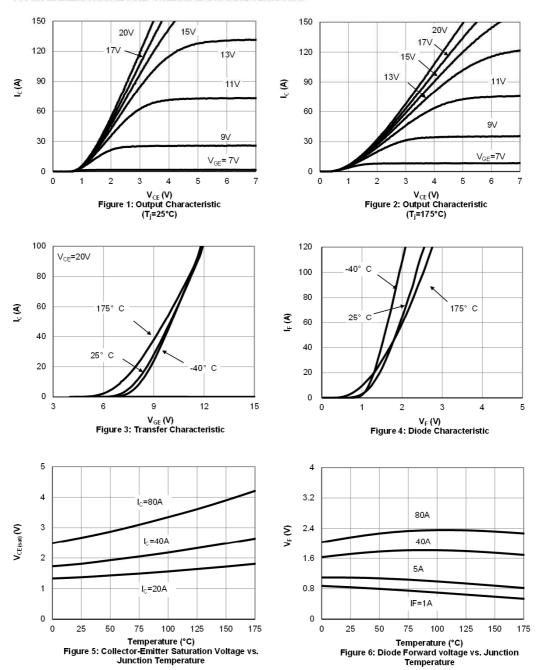


Electrical Characteristics (T_J=25°C unless otherwise noted)

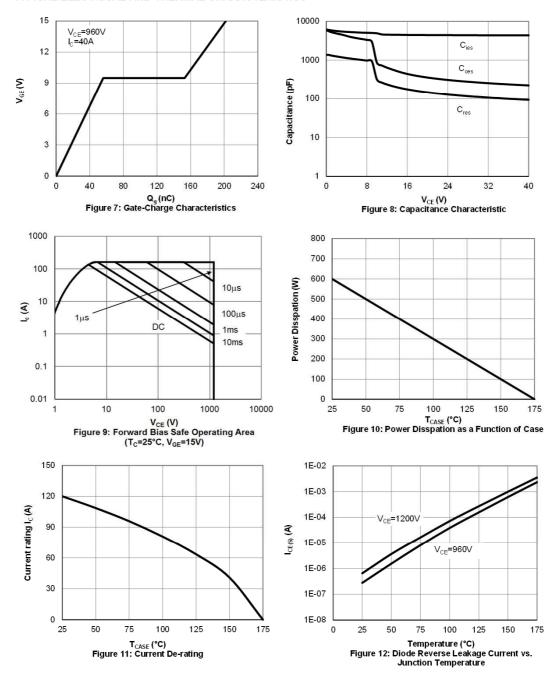
Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{CES}	Collector-Emitter Breakdown Voltage	I_C =1mA, V_{GE} =0V, T_J =25°0	1200	-	-	V	
V _{CE(sat)} Collector-Emitter Sati		V _{GE} =15V, I _C =40A	T _J =25°C	-	1.83	2.3	V
	Collector-Emitter Saturation Voltage		T _J =125°C	-	2.3	-	
			T _J =175°C	-	2.6	-	
			T _J =25°C	-	1.73	2.2	V
V_{F}	Diode Forward Voltage	V _{GE} =0V, I _F =40A	T _J =125°C	-	1.8	-	
			T _J =175°C	-	1.7	-	
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	V _{CE} =5V, I _C =1mA		4.8	5.7	6.5	V
	Zero Gate Voltage Collector Current	V _{CE} =1200V, V _{GE} =0V	T _J =25°C	-	-	10	μΑ
			T _J =125°C	-	-	2000	
			T _J =175°C	-	-	20000	
I _{GES}	Gate-Emitter Leakage Current	V _{CE} =0V, V _{GE} =±30V		-	-	±100	nA
g _{FS}	Forward Transconductance	V _{CF} =20V, I _C =40A		-	24	-	S
	PARAMETERS						
C _{ies}	Input Capacitance		-	4400	-	pF	
C _{oes}	Output Capacitance	V_{GE} =0V, V_{CC} =25V, f=1MH	-	300	-	pF	
C _{res}	Reverse Transfer Capacitance		-	125	-	pF	
Q_q	Total Gate Charge			-	202	-	nC
Q_{ge}	Gate to Emitter Charge	V_{GE} =15V, V_{CC} =960V, I_{C} =4	₌ =15V, V _{CC} =960V, I _C =40A		56	-	nC
Q _{qc}	Gate to Collector Charge		-	97	-	nC	
R _q	Gate Resistance V_{GE} =0V, V_{CC} =0V, f=1MHz				3	-	Ω
SWITCHI	NG PARAMETERS, (Load Inductive, T _J	=25°C)		•			
T _{d(on)}	Turn-On Delay Time			-	53	-	ns
T _r	Turn-On Rise Time	T_J =25°C V_{GE} =15V, V_{CC} =600V, I_C =40A, R_G =7.5 Ω		-	34	-	ns
T _{d(off)}	Turn-Off Delay Time			-	210	-	ns
T _f	Turn-Off Fall Time			-	36	-	ns
E _{on}	Turn-On Energy			-	2.5	-	mJ
E _{off}	Turn-Off Energy			-	1.3	-	mJ
E _{total}	Total Switching Energy		-	3.8	-	mJ	
T _{rr}	Diode Reverse Recovery Time	T -25°C		-	370	-	ns
Q _{rr}	Diode Reverse Recovery Charge	T _J =25°C	-	1.8	-	μC	
I _m	Diode Peak Reverse Recovery Current	I _F =40A, di/dt=200A/μs, V _{CC} =600V		-	10	-	Α
SWITCHI	NG PARAMETERS, (Load Inductive, T _J	=175°C)					
T _{d(on)}	Turn-On Delay Time			-	51	-	ns
T _r	Turn-On Rise Time			-	43	-	ns
T _{d(off)}	Turn-Off Delay Time	T_J =175°C V_{GE} =15V, V_{CC} =600V, I_C =40A, R_G =7.5 Ω		-	250	-	ns
T _f	Turn-Off Fall Time			-	132	-	ns
E _{on}	Turn-On Energy			-	3.3	-	mJ
E _{off}	Turn-Off Energy		-	2.5	-	mJ	
E _{total}	Total Switching Energy		-	5.8	-	mJ	
T _{rr}	Diode Reverse Recovery Time	T _47500		-	510	-	ns
Q _{rr}	Diode Reverse Recovery Charge	T _J =175°C I _E =40A, di/dt=200A/μs, V _C	-	5.2	-	μС	
I _{rm}	Diode Peak Reverse Recovery Current	ης-40A, αι/αι-200A/μS, V _C	-	17	-	A	

APPLICATIONS OR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

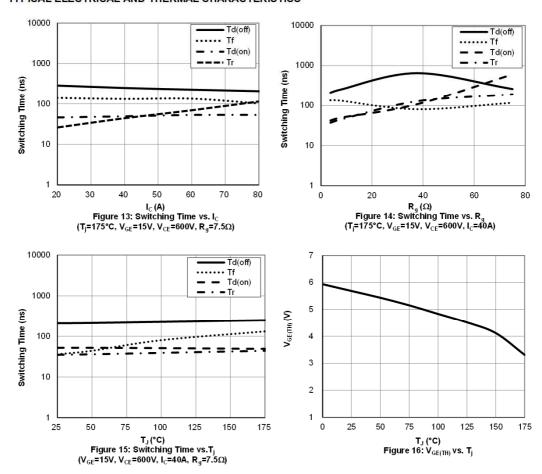




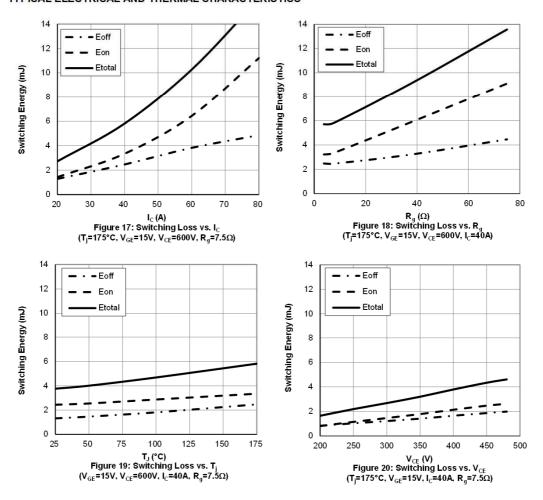












30

25

20

10

5

0

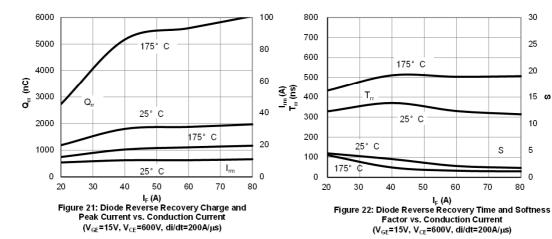
80

S

70

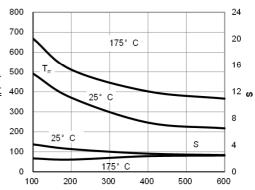
15 **ග**





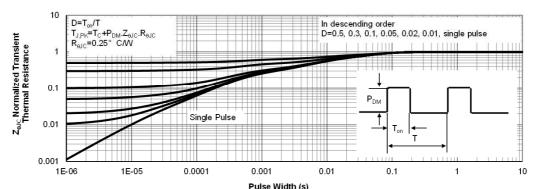
6000 100 5000 175° C 80 4000 I_{rm} (A) T_{rr} (ns) n S Q_{rr} 3000 ď 25° C 40 2000 175° C 20 1000 ${\rm I_{\rm rm}}$ 25° C 0 0 200 300 400 500 600 100

di/dt (A/μs)
Figure 23: Diode Reverse Recovery Charge and
Peak Current vs. di/dt
(V_{GE}=15V, V_{CE}=600V, I_F=40A)

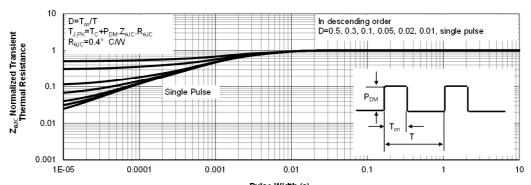


di/dt (A/ μ s)
Figure 24: Diode Reverse Recovery Time and Softness Factor vs. di/dt (V_{GE} =15V, V_{CE} =600V, I_F =40A)





Pulse Width (s) Figure 25: Normalized Maximum Transient Thermal Impedance for IGBT



Pulse Width (s)
Figure 26: Normalized Maximum Transient Thermal Impedance for Diode



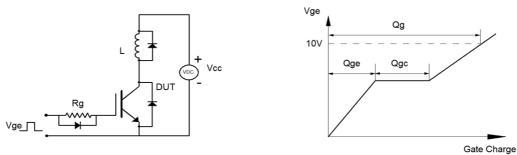


Figure A: Gate Charge Test Circuit & Waveforms

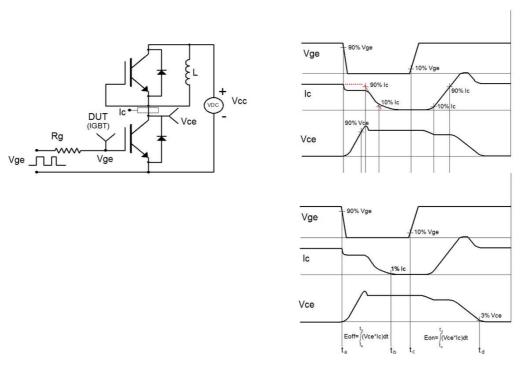


Figure B: Inductive Switching Test Circuit & Waveforms

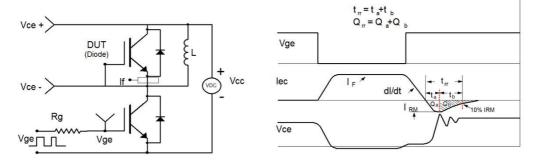


Figure C: Diode Recovery Test Circuit & Waveforms

单击下面可查看定价,库存,交付和生命周期等信息

>>AOS(万代)